

Test Report

According to

FCC PART 15 Subpart C

FCC ID: S29DEVO-8

Test Report Number: H1M21107-9239-P-15

Phone +852 2389 2200

+852 2389 3073

SLG Asia Test Labs & Service (HK) Limited 26/F., Tamson Plaza, 161 Wai Yip Street Kwun Tong, Kowloon, Hong Kong





TEST REPORT

Summary | FCC Part 15C

Test Report No. H1M21107-9239-P-15

Date of issue 24.08.2011

Kwun Tong, Kowloon, Hong Kong

Applicant's name GUANGZHOU Walkera Technology Co., Ltd.

Guangzhou, China

Manufacturer's name GUANGZHOU Walkera Technology Co., Ltd.

Guangzhou, China

Test specification

Standard(s) applied FCC Rules 47 CFR Part 15 Subpart C

Test item description Transmitter for R/C Helicopter

Brand Name: devention, WALKERA

Model and/or type reference: DEVO-8

Rating(s) 6 VDC (4x AA size batteries)

Summary of Test Results

Pass

The Summary of Test Results based on a technical opinion belongs to the applied standard(s).

Disclaimer

Further details of testing are provided in particular chapters of this Test Report.

This document base on General Terms and Conditions of SLG Asia Test Labs & Service (HK) Limited, which the applicant accepted with order confirmation.

Emphasized conditions or project related conditions:

Released Test Reports apply only to the specific samples tested under stated test conditions. It is the applicant's responsibility to assure that additional production units of the tested model(s) are manufactured in same construction and with identical electrical and mechanical components to meet the same quality as tested model(s). The applicant/manufacturer/importer is responsible for any modifications made to the production units which result in non-compliance to the applied and/or relevant regulations. SLG Asia Test Labs & Service (HK) Limited shall have no liability for any deductions, inferences or generalizations drawn by the client or others from any kind of issued reports. Reports are confidential property of the client. As a mutual protection to the applicant, the clients, the public and ourselves, extracts from the test report shall not be reproduced except in full without our written approval.



TABLE OF CONTENTS

1	General Information	3
1.1	Test Report	3
1.2	Test Location	4
1.3	Details of applicant	4
1.4	Manufacturer	4
1.5	Application details	5
1.6	Test item	5
1.7	General Test Conditions	6
2	Test result Summary	7
3	Test results	8
3.1.	6dB Bandwidth	8
3.2.	Output power	10
3.3.	Power Spectral Density	11
3.4.	Radiated spurious emission	12
4	Normative references	17
5	Disclaimer	18
5.1	Revision Notes	18
Annex:	A – Photos of test item Number of Page	es 4
Annex:	B – External Photos of test item Number of Page	es 5
Annex:	C – Internal Photos of test item Number of Page	es 1



1 General Information

1.1 Test Report

Tested by:

24.08.2011 Mr. Karl Lau

Date Test Engineer Signature

Approved by:

24.08.2011 Mr. F. Schulz

Date Laboratory Manager







1.2 Test Location

All tests were carrying by personnel from:

Name: SLG Asia Test Labs & Service (HK) Limited Address: 26/F., Tamson Plaza, 161 Wai Yip Street

Kwun Tong, Kowloon, Hong Kong

Telephone: +852 2389 2200 Fax: +852 2389 3073

The Test facility for radiated measurements is located at:

Name: Hong Kong Productivity Council

Address: EMC Centre, LG1, HKPC Building, 78 Tat Chee Avenue

Kowloon, Hong Kong

The Hong Kong Laboratory Accreditation Scheme (HOKLAS)

Reg. No.082

FCC registered measurement facility

Reg. No.90656

1.3 Details of applicant

Name: GUANGZHOU Walkera Technology Co., Ltd.

Address: Taishi Industrial Park, Dongchong Town, Panyu District

511475 Guangzhou, China

Contact: Mr. Ya

Telephone: +86 20 8491 5116 Fax: +86 20 8491 5117

1.4 Manufacturer

Name: GUANGZHOU Walkera Technology Co., Ltd.

Address: Taishi Industrial Park, Dongchong Town, Panyu District

511475 Guangzhou, China

Contact: Mr. Ya

Telephone: +86 20 8491 5116 Fax: +86 20 8491 5117





1.5 Application details

Date of receipt of application: 05.07.2011

Date of receipt of test item: 05.07.2011

Date (s) of performance of tests: 05.07.2011 - 24.08.2011

1.6 Test item

Description of test item: Transmitter for R/C Helicopter

Type identification: DEVO-8

Brand Name: devention, WALKERA

Equipment category: 2.4GHZ Spread Spectrum Transmitter

Equipment classification: Portable use Permitted frequency range: 2400 – 2483.5 MHz Operation frequency range: 2405 – 2479 MHz

Lowest Operation frequency: 2405 MHz Middles Operation frequency: 2441 MHz Highest Operation frequency: 2479 MHz Emission designator: F7D Antenna gain: ≤ 3 dBi Type of modulation: DSSS Operation mode: simplex Type of antenna: integral

Power supply: 6 VDC (4x AA size batteries)

All information was provided by the applicant)



1.7 General Test Conditions

Environmental reference conditions

If not defined otherwise by the Technical Committee responsible for the generic standard and/or the product standard the climatic conditions during the tests are to be within the limits specified by the manufacturer for the operation of the EUT and the test equipment.

The climatic conditions during the tests were within the following limits:

Temperature	Humidity	Atmospheric pressure
15 ℃ - 35 ℃	30 % - 60 %	860 hPa - 1060 hPa

If explicitly required in the test base (basic) the climatic values are recorded and documented separately for the respective test.

Calibration of measurement and test equipment

All measurement and testing equipment that has a significant influence on the accuracy of qualitative measurements and tests is subject to a periodical in-house system of calibration and servicing that is part of the quality management system of the EMC laboratory of SLG Asia Test Labs & Service (HK) Limited.

Measurement uncertainties

All tests are subject to measurement uncertainties. The overall measurement uncertainty of a measurement is defined as the range of which can be supposed that it contains the true value with a specified probability. This probability is 95 % for the generally specified measurement uncertainty (so-called expanded measurement uncertainty).

The limits for emission measurements and the test levels for immunity tests in the applied standards were defined taking into consideration the accuracy limits for measurement and testing equipment required by the basic standards.

All measurement and test results of the EMC laboratory of SLG Asia Test Labs & Service (HK) Limited fulfil the requirements for measurement uncertainties according to the standards applied.





2 Test result Summary

Digital Transmission system (2400-2483.5MHz)

FCC Rule	Test description	Results/Notes	Limits/Requirements	Verdict
15.247(a)	Digital modulation	System uses DSSS techniques		Р
15.247(a) (2)	6dB Bandwidth	> 880 KHz	> 500kHz	Р
15.247(b) (3)	Output power	19,77 dBm (0.095 W)	1W, EIRP limited to 4W	Р
15.247(d)	Power Spectral Density	3.69 dBm/3kHz	< 8dBm/3kHz	Р
15.247(c) / 15.209	Radiated Spurious Emissions 30MHz – 25GHz	All signals below Limits	15.207 restricted bands, all others < -20dBc	Р
15.203	RF Connector	EUT has integral antenna		Р
15.247 (b)/ 15.407 (f)	RF Exposure requirements	Refer to MPE calculation and User manual statement	Refer to OET 65	Р

Test case verdicts

P - Pass Test item does meet the requirement
 F - Fail Test item does not meet the requirement
 N.A. - Not Applicable Test case does not apply to the test object



3 Test results

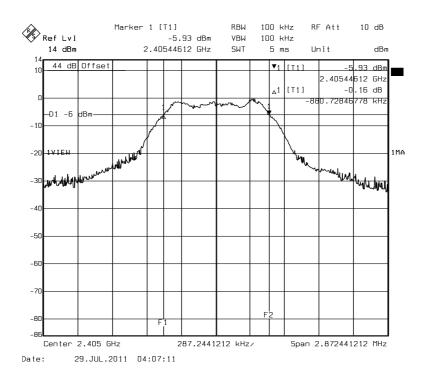
3.1. 6dB Bandwidth

Measurement Results:

FCC part 15.247 (a) (2): Signal Bandwidth

Frequency		6dB bandwidth (kHz)	Limit	Results
(MHz)	Resolution bandwidth		(kHz)	
2405	100kHz	880	>500	Pass
2441	100kHz	886	>500	Pass
2479	100kHz	880	>500	Pass

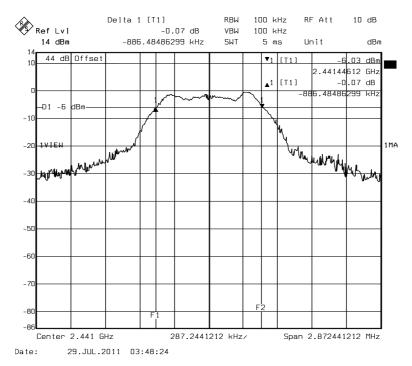
Lowest Operation frequency: 2405 MHz



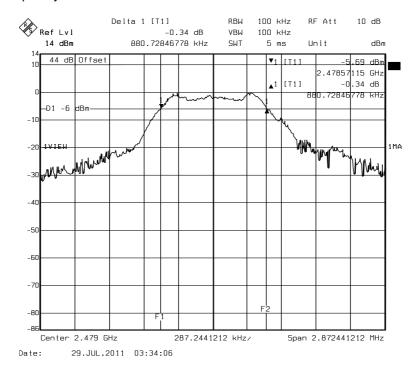


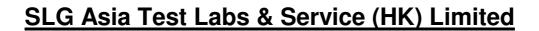


Middles Operation frequency: 2441 MHz



Highest Operation frequency: 2479 MHz







3.2. Output power

Measurement Results:

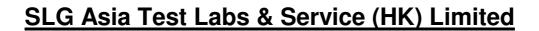
FCC part 15.247 (b) (3): Output Power

Ī	Frequency	Output Power		Antenna Gain	Results	EIF	RP
	MHz	dBm	mW	dBi		dBm	W
	2405	14.89	30.83	3	Pass	17.89	0.062
	2441	15.77	37.75	3	Pass	19.77	0.095
	2479	15.94	39.26	3	Pass	18.94	0.078

All results were measured with peak power meter.

Measurement Equipment Used:

Test equipment	Туре	S/N	Manufacturer	Cal Due Date
Spectrum Analyzer	FSEK 20	836043/003	Rohde & Schwarz	Sep 11





3.3. Power Spectral Density

Measurement Results:

FCC part 15.247 (d): Power spectral Density

Frequency	PSD	Limit	Results
MHz	dBm/3kHz	dBm/3kHz	
2405	2.86	8	Pass
2441	3.06	8	Pass
2479	3.69	8	Pass

Note 1:	Power spectral density measured using RBW=3kHz, VBW=10kHz, analyzer with peak detector and with a sweep time set to ensure a dwell time of at least 1 second per 3kHz. The measurement is made at the frequency of PPSD determined from preliminary scans
	using

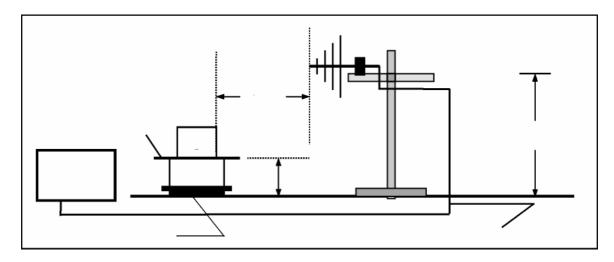
Measurement Equipment Used:

Test equipment	Туре	S/N	Manufacturer	Cal Due Date
Spectrum Analyzer	FSEK 20	836043/003	Rohde & Schwarz	Sep 11



3.4. Radiated spurious emission

Measurement Procedure



The equipment under test is placed on a non metallic table with 0.8 m height.

The power supply and the RF connection points are close to the equipment under test at the floor inside a connection box. The cables to this connection box are shielded and below the double floor. The receiving antenna is placed in a height at 1.0 m to 4.0 m and in a distance of 3 m.

Measurement Equipment Used:

Test equipment	Туре	S/N	Manufacturer	Cal Due Date
Semi-anechoic Chamber	Nil	Nil	Frankonia	May 12
Test Reciever	ESU 26	100050	Rohde & Schwarz	Aug 11
Bi-conical Antenna	HK116	841489/016	Rohde & Schwarz	Mar 12
LogPeriodic Antenna	HL223	841516/020	Rohde & Schwarz	Feb 12
Horn Antenna	3115	9002-3351	EMCO	Feb 12
Active Loop Antenna	6502	9107-2651	EMCO	Dec 11



Measurement Results:

Low Frequency @ 2405 MHz

Fundamenta	al emission leve	el @3m in 100	khz RBV	1	13.11	dBμV/m
Limit for er	nission outside	of restricted	l bands:	!	93.11	dBμV/m
Frequency	Level	Pol	15.209/1	5.247	Detector	Comments
MHz	dBμV/m	V/H	Limit	Margin	Pk/QP/Avg	
195,912	31.98	٧	43.5	11.52	Pk	RB/VB 100kHz
143.447	29.51	Н	43.5	13.99	Pk	RB/VB 100kHz
208.016	33.13	V	43.5	10.37	Pk	RB/VB 100kHz
200.000	23.20	Н	43.5	20.30	Pk	RB/VB 100kHz
4810	47.81	V	74	26.19	Pk	RB/VB 1MHz
4810	52.88	Н	74	21.12	Pk	RB/VB 1MHz
7214.42	42.48	V	93.11	50.63	Pk	RB/VB 1MHz
7214.42	43.60	Н	93.11	49.51	Pk	RB/VB 1MHz
9618.23	34,63	V	93.11	58.48	Pk	RB/VB 1MHz
9618.23	36.40	Н	93.11	56.71	Pk	RB/VB 1MHz
12027	44.90	V	74	29.10	Pk	RB/VB 1MHz
12027	42.70	Н	74	31.30	Pk	RB/VB 1MHz

For emission in restricted band, the limit of 15,209 was used. For all other emission, the limit was set 20dB below the level of fundamental and measured in 100kHz





Middle Frequency @ 2441 MHz

Fundamental emission level @3m in 100khz RBV	114.99	dBμV/m
Limit for emission outside of restricted bands:	94.99	dBμV/m

Frequency	Level	Pol	15.209/1	5.247	Detector	Comments
MHz	dBmV/m	V/H	Limit	Margin	Pk/QP/Avg	
187.054	31.86	V	43.5	11.64	Pk	RB/VB 100kHz
96.433	29.56	Н	43.5	13.94	Pk	RB/VB 100kHz
200	34.16	V	43.5	9.34	Pk	RB/VB 100kHz
858.918	22.87	Н	46	23.13	Pk	RB/VB 100kHz
4882	55.27	V	74	18.73	Pk	RB/VB 1MHz
4882	57.85	Н	74	16.15	Pk	RB/VB 1MHz
7326.65	40.38	>	74	33.62	Pk	RB/VB 1MHz
7326.65	38.34	Н	74	35.66	Pk	RB/VB 1MHz
9761.02	37.09	V	94.99	57.90	Pk	RB/VB 1MHz
9761.02	35.75	Н	94.99	59.24	Pk	RB/VB 1MHz
12207	42.52	V	74	31.48	Pk	RB/VB 1MHz
12731	41.94	Н	94.99	53.05	Pk	RB/VB 1MHz

For emission in restricted band, the limit of 15.209 was used. For all other emission, the limit was set 20dB below the level of fundamental and measured in 100kHz





High Frequency @ 2479 MHz

Fundamental emission level @3m in 100khz RBV	114.68	dBμV/m
Limit for emission outside of restricted bands:	94.68	dBμV/m

BmV/m 33.13	V/H	Limit	Margin	DI-/OD/A	
33.13	W		Margin	Pk/QP/Avg	
	V	43.5	10.37	Pk	RB/VB 100kHz
29.80	Н	43.5	13.70	Pk	RB/VB 100kHz
34.10	V	43.5	9.40	Pk	RB/VB 100kHz
22.55	Н	46	23.45	Pk	RB/VB 100kHz
56.32	V	74	17.68	Pk	RB/VB 1MHz
55.06	Н	74	18.94	Pk	RB/VB 1MHz
38.79	V	74	35.21	Pk	RB/VB 1MHz
37.95	Н	74	36.05	Pk	RB/VB 1MHz
35.28	V	94.68	59.40	Pk	RB/VB 1MHz
42.19	Н	94.69	52.50	Pk	RB/VB 1MHz
42.07	V	74	31.93	Pk	RB/VB 1MHz
41.77	Н	74	32.23	Pk	RB/VB 1MHz
	34.10 22.55 56.32 55.06 38.79 37.95 35.28 42.19 42.07	34.10 V 22.55 H 56.32 V 55.06 H 38.79 V 37.95 H 35.28 V 42.19 H	34.10 V 43.5 22.55 H 46 56.32 V 74 55.06 H 74 38.79 V 74 37.95 H 74 35.28 V 94.68 42.19 H 94.69 42.07 V 74	34.10 V 43.5 9.40 22.55 H 46 23.45 56.32 V 74 17.68 55.06 H 74 18.94 38.79 V 74 35.21 37.95 H 74 36.05 35.28 V 94.68 59.40 42.19 H 94.69 52.50 42.07 V 74 31.93	34.10 V 43.5 9.40 Pk 22.55 H 46 23.45 Pk 56.32 V 74 17.68 Pk 55.06 H 74 18.94 Pk 38.79 V 74 35.21 Pk 37.95 H 74 36.05 Pk 35.28 V 94.68 59.40 Pk 42.19 H 94.69 52.50 Pk 42.07 V 74 31.93 Pk

For emission in restricted band the limit of 15.209 was used. For all other emission. the limit was set 20dB below the level of fundamental and measured in 100kHz

Note: Testing is carried out with frequency rang 30MHz to the tenth harmonics which above 5th Harmonics is close to the noise base even antenna close up to 1meter distance according the measurement of ANSI C63.4. Emissions 20dB lower than the limit are not reported.



FCC Part 15. Subpart C. §15.209. Radiated Emission Limits

Frequency of Emission [MHz]	Field strength [μV/m]	Field Strength [dBμV/m]
30 – 88	100	40.0
88 – 216	150	43.5
216 – 960	200	46.0
Above 960	500	54.0

FCC Part 15. Subpart C. §15.205. Restricted bands of operation

MHz	MHz	MHz	GHz
0.090 - 0.110 10.495 - 0.505	16.42 - 16.423 16.69475 - 16.69525	399.9 - 410 608 - 614	4.5 - 5.15 5.35 - 5.46
2.1735 - 2.1905	16.80425 - 16.80475	960 - 1240	7.25 - 7.75
4.125 - 4.128	25.5 - 25.67	1300 - 1427	8.025 - 8.5
4.17725 - 4.17775	37.5 - 38.25	1435 - 1626.5	9.0 - 9.2
4.20725 - 4.20775	73 - 74.6	1645.5 - 1646.5	9.3 - 9.5
6.215 - 6.218	74.8 - 75.2	1660 - 1710	10.6 - 12.7
6.26775 - 6.26825	108 - 121.94	1718.8 - 1722.2	13.25 - 13.4
6.31175 - 6.31225	123 - 138	2200 - 2300	14.47 - 14.5
8.291 - 8.294	149.9 - 150.05	2310 - 2390	15.35 - 16.2
8.362 - 8.366	156.52475 - 156.52525	2483.5 - 2500	17.7 - 21.4
8.37625 - 8.38675	156.7 - 156.9	2690 - 2900	22.01 - 23.12
8.41425 - 8.41475	162.0125 - 167.17	3260 - 3267	23.6 - 24.0
12.29 - 12.293	167.72 - 173.2	3332 - 3339	31.2 - 31.8
12.51975 - 12.52025	240 - 285	3345.8 - 3358	36.43 - 36.5
12.57675 - 12.57725	322 - 335.4	3600 - 4400	
13.36-13.41			





4 Normative references

- /1/ FCC Rules 47 CFR PART 15 Subpart: 2010 Radio Frequency Devises
- /2/ ANSI C63.4-2003
 Methods of Measurement of Radio-Noise Emission from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz



5 Disclaimer

This document based on General Terms and Conditions of SLG Asia Test Labs & Service (HK) Limited. which the applicant accepted with order confirmation.

Emphasized conditions or project related conditions:

Released Test Reports apply only to the specific samples tested under stated test conditions. It is the applicant's responsibility to assure that additional production units of the tested model(s) are manufactured in same construction and with identical electrical and mechanical components to meet the same quality as tested model(s). The applicant/manufacturer/importer is responsible for any modifications made to the production units which result in non-compliance to the applied and/or relevant regulations.

SLG Asia Test Labs & Service (HK) Limited shall have no liability for any deductions. inferences or generalizations drawn by the client or others from any kind of issued reports. Reports are confidential property of the client as a mutual protection to the applicant the clients. The public and ourselves extracts from the test report shall not be reproduced except in full without our written approval.

The purpose of conformity testing is to increase the probability of adherence to the essential requirements or conformity specifications. as appropriate. The complexity of the technical specifications means that full and thorough testing is impractical for both technical and economic reasons. Furthermore there is no guarantee that a test sample which has passed all the relevant tests conforms to a specification. Neither is there any guarantee that such a test sample will interact with other genuinely open systems. The existence of the tests nevertheless provides the confidence that the test sample possesses the qualities as maintained and that its performance generally conforms to representative cases of communications equipment.

The test results of this test report relate exclusively to the item tested as specified in clause 1.6 of this report. The test report may only be reproduced or published in full.

Reproducing or publishing extracts of the report requires the prior written approval of SLG Asia Test Labs & Service (HK) Limited.

5.1 Revision Notes

This revised Report replaces the all former Test Reports based on number H1M21107-9239-P-15. These former Test Reports are not longer valid. Every Revision of the original report is recorded below and identified by the \parallel symbol beside the text.

Revision No.	Revision
H1M21107-9239-P-15	Original Test Report